

Notice of References Cited	Application/Control No. 10/551,222		Applicant(s)/Patent Under Reexamination TABUCHI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,591,391	01-1997	Igarashi et al.	420/38
*	C	US-5,650,024	07-1997	Hasegawa et al.	148/326
*	D	US-2,586,042	02-1952	HODGE JOHN M; et. al.	420/91
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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